











SNVS424D - JANUARY 2006-REVISED DECEMBER 2014

LM5106

# LM5106 100-V Half-Bridge Gate Driver With Programmable Dead-Time

#### **Features**

- Drives Both a High-Side and Low-Side N-Channel
- 1.8-A Peak Output Sink Current
- 1.2-A Peak Output Source Current
- Bootstrap Supply Voltage Range up to 118-V DC
- Single TTL Compatible Input
- Programmable Turnon Delays (Dead-Time)
- **Enable Input Pin**
- Fast Turnoff Propagation Delays (32 ns Typical)
- Drives 1000 pF With 15-ns Rise and 10-ns Fall
- Supply Rail Undervoltage Lockout
- Low Power Consumption
- 10-Pin WSON Package (4 mm × 4 mm) and 10-Pin VSSOP Package

### Applications

- Solid-State Motor Drives
- Half-Bridge and Full-Bridge Power Converters
- Two Switch Forward Power Converters

#### 3 Description

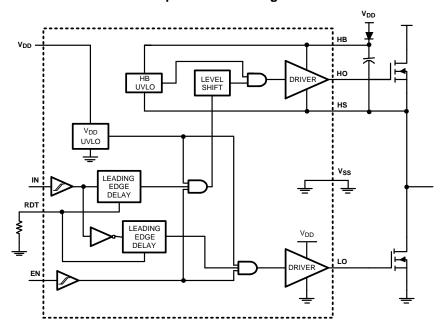
The LM5106 is a high-voltage gate driver designed to drive both the high-side and low-side N-channel MOSFETs in a synchronous buck or half-bridge configuration. The floating high-side driver can work with rail voltages up to 100 V. The single control input is compatible with TTL signal levels and a single external resistor programs the switching transition dead-time through tightly matched turnon delay circuits. The robust level shift technology operates at high speed while consuming low power and provides clean output transitions. Undervoltage lockout (UVLO) disables the gate driver when either the low side or the bootstrapped high-side supply voltage is below the operating threshold. The LM5106 is offered in the 10-pin VSSOP or the thermally enhanced 10pin WSON plastic package.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LM5106	VSSOP (10)	3.00 mm × 3.00 mm
	WSON (10)	4.00 mm × 4.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

#### **Simplified Block Diagram**



**Page** 



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#### 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

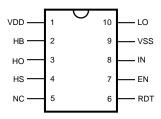
# Changes from Revision C (March 2013) to Revision D Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Functional

# Changes from Revision B (March 2013) to Revision C Page Changed layout of National Data Sheet to TI format



# 5 Pin Configuration and Functions





#### **Pin Functions**

	NIN I		riii runctions
PIN		DESCRIPTION	APPLICATION INFORMATION
NO.	NAME	<b>3200</b> 1111 11011	71. 7 2.07.110.11 11.1 01.111.7 11.0 11
1	VDD	Positive gate drive supply	Decouple VDD to VSS using a low ESR/ESL capacitor, placed as close to the IC as possible.
2	НВ	High-side gate driver bootstrap rail	Connect the positive terminal of bootstrap capacitor to the HB pin and connect negative terminal to HS. The Bootstrap capacitor should be placed as close to IC as possible.
3	НО	High-side gate driver output	Connect to the gate of high-side N-MOS device through a short, low inductance path.
4	HS	High-side MOSFET source connection	Connect to the negative terminal of the bootststrap capacitor and to the source of the high-side N-MOS device.
5	NC	Not connected	
6	RDT	Dead-time programming pin	A resistor from RDT to VSS programs the turnon delay of both the high- and low-side MOSFETs. The resistor should be placed close to the IC to minimize noise coupling from adjacent PC board traces.
7	EN	Logic input for driver Disable/Enable	TTL compatible threshold with hysteresis. LO and HO are held in the low state when EN is low.
8	IN	Logic input for gate driver	TTL compatible threshold with hysteresis. The high-side MOSFET is turned on and the low-side MOSFET turned off when IN is high.
9	VSS	Ground return	All signals are referenced to this ground.
10	LO	Low-side gate driver output	Connect to the gate of the low-side N-MOS device with a short, low inductance path.
_	EP	Exposed Pad	The exposed pad has no electrical contact. Connect to system ground plane for reduced thermal resistance.



#### 6 Specifications

#### 6.1 Absolute Maximum Ratings<sup>(1)(2)</sup>

	MIN	MAX	UNIT
V <sub>DD</sub> to V <sub>SS</sub>	-0.3	18	V
HB to HS	-0.3	18	V
IN and EN to V <sub>SS</sub>	-0.3	V <sub>DD</sub> + 0.3	V
LO to V <sub>SS</sub>	-0.3	V <sub>DD</sub> + 0.3	V
HO to V <sub>SS</sub>	HS - 0.3	HB + 0.3	V
HS to V <sub>SS</sub> <sup>(3)</sup>		100	V
HB to V <sub>SS</sub>		118	V
RDT to V <sub>SS</sub>	-0.3	5	V
Junction Temperature		150	°C
Storage temperature range, T <sub>stg</sub>	-55	150	°C

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the component may occur. Recommended Operating Conditions are conditions under which operation of the device is ensured. Operating Ratings do not imply ensured performance limits. For ensured performance limits and associated test conditions, see the Electrical Characteristics.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.
- (3) In the application the HS node is clamped by the body diode of the external lower N-MOSFET, therefore the HS voltage will generally not exceed –1 V. However in some applications, board resistance and inductance may result in the HS node exceeding this stated voltage transiently. If negative transients occur on HS, the HS voltage must never be more negative than V<sub>DD</sub> 15 V. For example, if V<sub>DD</sub> = 10 V, the negative transients at HS must not exceed –5 V.

#### 6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±1500	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

#### 6.3 Recommended Operating Conditions

	MIN	MAX	UNIT
$V_{DD}$	8	14	V
HS <sup>(1)</sup>	-1	100	V
НВ	HS + 8	HS + 14	V
HS Slew Rate		< 50	V/ns
Junction Temperature	-40	125	°C

(1) In the application the HS node is clamped by the body diode of the external lower N-MOSFET, therefore the HS voltage will generally not exceed –1 V. However in some applications, board resistance and inductance may result in the HS node exceeding this stated voltage transiently. If negative transients occur on HS, the HS voltage must never be more negative than V<sub>DD</sub> - 15 V. For example, if V<sub>DD</sub> = 10 V, the negative transients at HS must not exceed –5 V.

Product Folder Links: LM5106



#### 6.4 Thermal Information

			LM5102		
	THERMAL METRIC <sup>(1)</sup>	DGS	DPR <sup>(2)</sup>	UNIT	
		10 PINS	10 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	165.3	37.9		
R <sub>0</sub> JC(top)	Junction-to-case (top) thermal resistance	58.9	38.1		
$R_{\theta JB}$	Junction-to-board thermal resistance	54.4	14.9	°C/W	
$\Psi_{JT}$	Junction-to-top characterization parameter	6.2	0.4	10/00	
ΨЈВ	Junction-to-board characterization parameter	83.6	15.2		
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	4.4		

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

#### 6.5 Electrical Characteristics

MIN and MAX limits apply over the full operating junction temperature range. Unless otherwise specified,  $T_J$  = +25°C,  $V_{DD}$  = HB = 12 V,  $V_{SS}$  = HS = 0 V, EN = 5 V. No load on LO or HO. RDT= 100k $\Omega^{(1)}$ .

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY CU	RRENTS				*	
I <sub>DD</sub>	V <sub>DD</sub> Quiescent Current	IN = EN = 0 V		0.34	0.6	mA
I <sub>DDO</sub>	V <sub>DD</sub> Operating Current	f = 500 kHz		2.1	3.5	mA
I <sub>HB</sub>	Total HB Quiescent Current	IN = EN = 0 V		0.06	0.2	mA
I <sub>HBO</sub>	Total HB Operating Current	f = 500 kHz		1.5	3	mA
I <sub>HBS</sub>	HB to V <sub>SS</sub> Current, Quiescent	HS = HB = 100 V		0.1	10	μΑ
I <sub>HBSO</sub>	HB to V <sub>SS</sub> Current, Operating	f = 500 kHz		0.5		mA
INPUT IN an	d EN					
V <sub>IL</sub>	Low Level Input Voltage Threshold		0.8	1.8		V
V <sub>IH</sub>	High Level Input Voltage Threshold			1.8	2.2	V
R <sub>pd</sub>	Input Pulldown Resistance Pin IN and EN		100	200	500	kΩ
DEAD-TIME	CONTROLS					
VRDT	Nominal Voltage at RDT		2.7	3	3.3	V
IRDT	RDT Pin Current Limit	RDT = 0 V	0.75	1.5	2.25	mA
UNDERVOL	TAGE PROTECTION		•			
$V_{DDR}$	V <sub>DD</sub> Rising Threshold		6.2	6.9	7.6	V
$V_{DDH}$	V <sub>DD</sub> Threshold Hysteresis			0.5		V
$V_{HBR}$	HB Rising Threshold		5.9	6.6	7.3	V
V <sub>HBH</sub>	HB Threshold Hysteresis			0.4		V
LO GATE DE	RIVER					
V <sub>OLL</sub>	Low-Level Output Voltage	I <sub>LO</sub> = 100 mA		0.21	0.4	V
V <sub>OHL</sub>	High-Level Output Voltage	$I_{LO} = -100 \text{ mA},$ $V_{OHL} = V_{DD} - V_{LO}$		0.5	0.85	V
I <sub>OHL</sub>	Peak Pullup Current	LO = 0 V		1.2		Α
I <sub>OLL</sub>	Peak Pulldown Current	LO = 12 V		1.8		Α
HO GATE DI	RIVER	·	•		1	
V <sub>OLH</sub>	Low-Level Output Voltage	I <sub>HO</sub> = 100 mA		0.21	0.4	V
V <sub>OHH</sub>	High-Level Output Voltage	I <sub>HO</sub> = -100 mA, V <sub>OHH</sub> = HB - HO		0.5	0.85	V

<sup>(1)</sup> Min and Max limits are 100% production tested at 25°C. Limits over the operating temperature range are ensured through correlation using Statistical Quality Control (SQC) methods. Limits are used to calculate Average Outgoing Quality Level (AOQL).

<sup>(2)</sup> Four-layer board with Cu finished thickness 1.5 oz, 1 oz, 1 oz, 1 oz, 1.5 oz. Maximum die size used. 5x body length of Cu trace on PCB top. 50-mm x 50-mm ground and power planes embedded in PCB. See Application Note *AN-1187 Leadless Leadframe Package (LLP)* (SNOA401).



#### **Electrical Characteristics (continued)**

MIN and MAX limits apply over the full operating junction temperature range. Unless otherwise specified,  $T_J$  = +25°C,  $V_{DD}$  = HB = 12 V,  $V_{SS}$  = HS = 0 V, EN = 5 V. No load on LO or HO. RDT= 100k $\Omega^{(1)}$ .

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
I <sub>OHH</sub>	Peak Pullup Current	HO = 0 V		1.2		Α
I <sub>OLH</sub>	Peak Pulldown Current	HO = 12 V		1.8		Α
THERMAL RESISTANCE						
$\theta_{JA}$	Junction to Ambient	See <sup>(2)(3)</sup>		40		°C/W

<sup>(2)</sup> Four-layer board with Cu finished thickness 1.5/1.0/1.0/1.5 oz. Maximum die size used. 5x body length of Cu trace on PCB top. 50-mm x 50-mm ground and power planes embedded in PCB. See AN-1187 Leadless Leadframe Package (LLP), SNOA401.

#### 6.6 Switching Characteristics

MIN and MAX limits apply over the full operating junction temperature range. Unless otherwise specified,  $T_J = +25$ °C,  $V_{DD} = HB = 12 \text{ V}$ ,  $V_{SS} = HS = 0 \text{ V}$ , No Load on LO or  $HO^{(1)}$ .

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>LPHL</sub>	Lower Turn-Off Propagation Delay			32	56	ns
t <sub>HPHL</sub>	Upper Turn-Off Propagation Delay			32	56	
t <sub>LPLH</sub>	Lower Turn-On Propagation Delay	RDT = 100k	400	520	640	
t <sub>HPLH</sub>	Upper Turn-On Propagation Delay	RDT = 100k	450	570	690	
t <sub>LPLH</sub>	Lower Turn-On Propagation Delay	RDT = 10k	85	115	160	
t <sub>HPLH</sub>	Upper Turn-On Propagation Delay	RDT = 10k	85	115	160	
t <sub>en</sub> , t <sub>sd</sub>	Enable and Shutdown propagation delay			36		
DT1, DT2	Dead-time LO OFF to HO ON & HO OFF to	RDT = 100k		510		
	LO ON	RDT = 10k		86		
MDT	Dead-time matching	RDT = 100k		50		
t <sub>R</sub>	Either Output Rise Time	C <sub>L</sub> = 1000pF		15		
t <sub>F</sub>	Either Output Fall Time	C <sub>L</sub> = 1000pF		10		

(1) Min and Max limits are 100% production tested at 25°C. Limits over the operating temperature range are ensured through correlation using Statistical Quality Control (SQC) methods. Limits are used to calculate Average Outgoing Quality Level (AOQL).

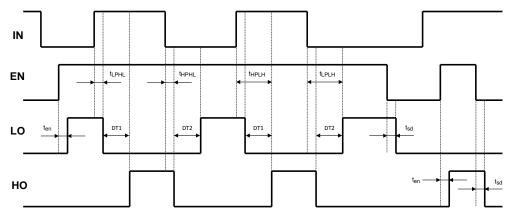


Figure 1. LM5106 Input - Output Waveforms

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<sup>(3)</sup> The θ<sub>JA</sub> is not a constant for the package and depends on the printed circuit board design and the operating conditions.



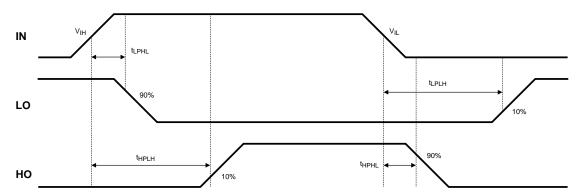


Figure 2. LM5106 Switching Time Definitions:  $t_{LPLH}$ ,  $t_{LPHL}$ ,  $t_{HPLH}$ ,  $t_{HPHL}$ 

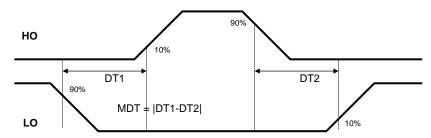
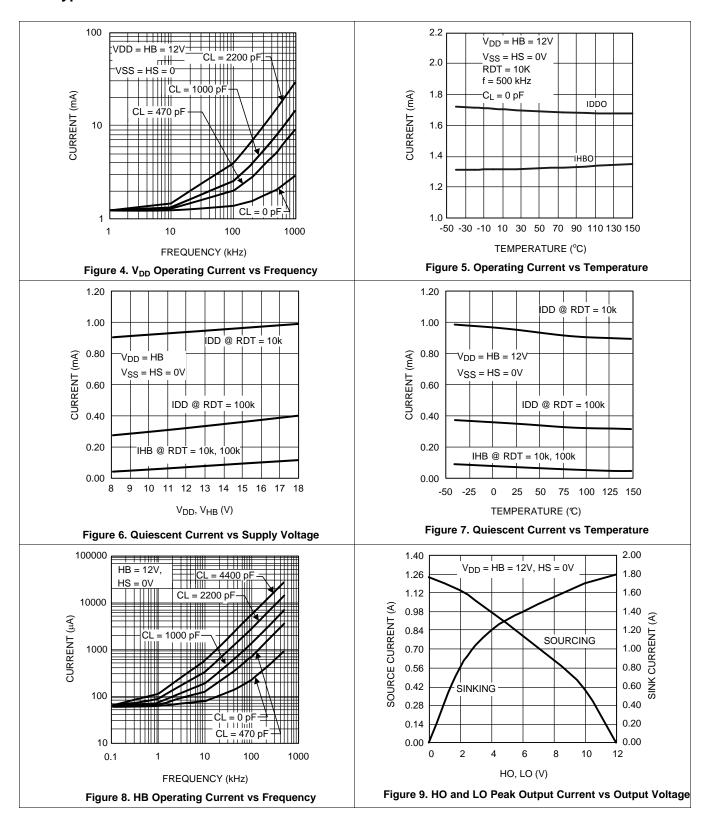


Figure 3. LM5106 Dead-time: DT

# TEXAS INSTRUMENTS

#### 6.7 Typical Characteristics





#### **Typical Characteristics (continued)**

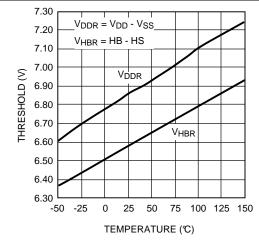
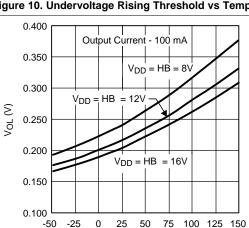


Figure 10. Undervoltage Rising Threshold vs Temperature



TEMPERATURE (℃) Figure 12. LO and HO - Low-Level Output Voltage vs **Temperature** 

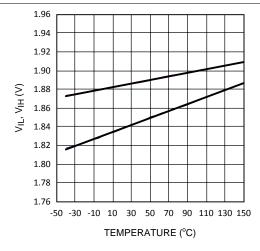


Figure 14. Input Threshold vs Temperature

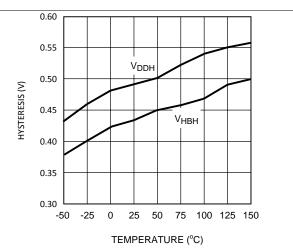


Figure 11. Undervoltage Hysteresis vs Temperature

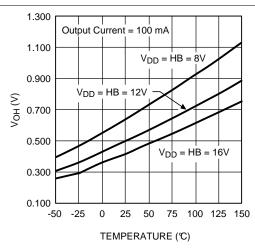


Figure 13. LO and HO - High-Level Output Voltage vs **Temperature** 

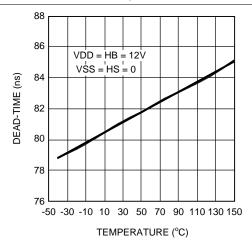
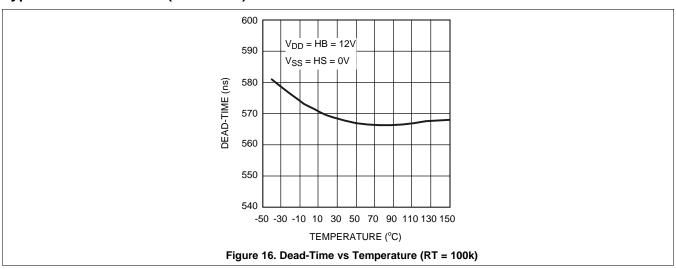


Figure 15. Dead-Time vs Temperature (RT = 10k)



# **Typical Characteristics (continued)**





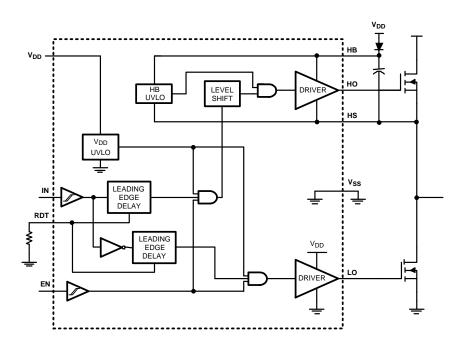
#### 7 Detailed Description

#### 7.1 Overview

The LM5106 is a single PWM input gate driver with Enable that offers a programmable dead-time. The dead-time is set with a resistor at the RDT pin and can be adjusted from 100 ns to 600 ns. The wide dead-time programming range provides the flexibility to optimize drive signal timing for a wide range of MOSFETs and applications.

The RDT pin is biased at 3 V and current limited to 1 mA maximum programming current. The time delay generator will accommodate resistor values from 5k to 100k with a dead-time time that is proportional to the RDT resistance. Grounding the RDT pin programs the LM5106 to drive both outputs with minimum dead-time.

#### 7.2 Functional Block Diagram



#### 7.3 Feature Description

#### 7.3.1 Start-up and UVLO

Both top and bottom drivers include undervoltage lockout (UVLO) protection circuitry which monitors the supply voltage ( $V_{DD}$ ) and bootstrap capacitor voltage (HB – HS) independently. The UVLO circuit inhibits each driver until sufficient supply voltage is available to turn on the external MOSFETs, and the UVLO hysteresis prevents chattering during supply voltage transitions. When the supply voltage is applied to the  $V_{DD}$  pin of the LM5106, the top and bottom gates are held low until  $V_{DD}$  exceeds the UVLO threshold, typically about 6.9 V. Any UVLO condition on the bootstrap capacitor will disable only the high-side output (HO).

#### 7.4 Device Functional Modes

EN	IN Pin	LO Pin	HO Pin
L	Any	L	L
Н	Н	L	Н
Н	L	Н	L



## 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 8.1 Application Information

The LM5106 is one of the latest generation of high-voltage gate drivers which are designed to drive both the high-side and low-side N-channel MOSFETs in a half-bridge/full bridge configuration or in a synchronous buck circuit. The floating high-side driver can operate with supply voltages up to 110 V. This allows for N-channel MOSFET control in half-bridge, full-bridge, push-pull, two switch forward and active clamp topologies.

The outputs of the LM5106 are controlled from a single input. The rising edge of each output can be delayed with a programming resistor.

Table 1. Highlights

FEATURE	BENEFIT				
Programmable Turnon Delay	Allows optimization of gate drive timings in bridge topologies				
Enable Pin	Reduces operating current when disabled to improved power system standby power				
Low Power Consumption	Improves light load efficiency figures of the power stage.				

#### 8.2 Typical Application

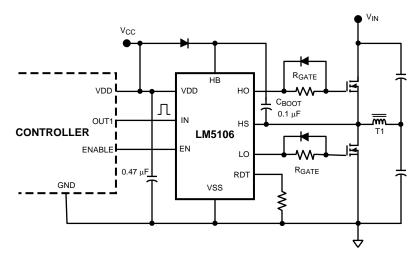


Figure 17. LM5106 Driving MOSFETs Connected in Half-Bridge Configuration



#### **Typical Application (continued)**

#### 8.2.1 Design Requirements

PARAMETERS	VALUES
Gate Drive IC	LM5102
Mosfet	CSD18531Q5A
$V_{DD}$	10 V
$Q_{gmax}$	43 nC
F <sub>sw</sub>	100 kHz
D <sub>Max</sub>	95%
І <sub>нво</sub>	10 μΑ
$V_{DH}$	1.1 V
V <sub>HBR</sub>	7.3 V
V <sub>HBH</sub>	0.4 V

#### 8.2.2 Detailed Design Procedure

#### 8.2.2.1 Detailed Design Procedure

$$\Delta V_{HB} = V_{DD} - V_{DH} - V_{HBL}$$

where

- V<sub>DD</sub> = Supply voltage of the gate drive IC
- V<sub>DH</sub> = Bootstrap diode forward voltage drop

• 
$$V_{gsmin}$$
 = Minimum gate source threshold voltage (1)

$$C_{BOOT} = \frac{Q_{TOTAL}}{\Lambda V_{HB}}$$

 $\Delta V_{HB}$  (2)

$$Q_{TOTAL} = Q_{gmax} + I_{HBO} \times \frac{D_{Max}}{F_{sw}}$$
(3)

The quiescent current of the bootstrap circuit is 10 µA which is negligible compared to the Qgs of the MOSFET.

$$Q_{\text{TOTAL}} = 43nC + 10\mu\text{A} \times \frac{0.95}{100\text{kHz}} \tag{4}$$

$$Q_{TOTAL} = 43.01 \text{ nC}$$
 (5)

In practice the value for the  $C_{\mathsf{BOOT}}$  capacitor should be greater than that calculated to allow for situations where the power stage may skip pulse due to load transients. In this circumstance the boot capacitor must maintain the HB pin voltage above the UVLO voltage for the HB circuit.

As a general rule the local V<sub>DD</sub> bypass capacitor should be 10 times greater than the value of C<sub>BOOT</sub>.

$$V_{HBL} = V_{HBR} - V_{HBH}$$
 (6)

$$V_{HBL} = 6.9 \text{ V}$$
 (7)

$$\Delta V_{HB} = 10 \text{ V} - 1.1 \text{ V} - 6.9 \text{ V}$$
 (8)

$$\Delta V_{HB} = 2.0 \text{ V} \tag{9}$$

$$C_{BOOT} = 43.01 \text{nc} / 2 \text{ V}$$
 (10)

$$C_{BOOT} = 21.5 \text{ nF} \tag{11}$$

The bootstrap and bias capacitors should be ceramic types with X7R dielectric. The voltage rating should be twice that of the maximum VDD to allow for loss of capacitance once the devices have a DC bias voltage across them and to ensure long-term reliability of the devices.

The resistor values, RT, for setting turnon delay can be found in Figure 19.

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#### 8.2.3 Application Curves

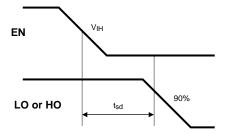


Figure 18. LM5106 Enable: t<sub>sd</sub>

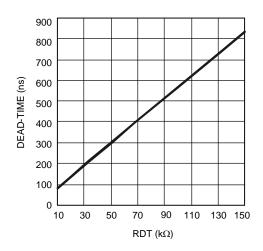


Figure 19. Dead-Time vs RT Resistor Value

#### 9 Power Supply Recommendations

#### 9.1 Power Dissipation Considerations

The total IC power dissipation is the sum of the gate driver losses and the bootstrap diode losses. The gate driver losses are related to the switching frequency (f), output load capacitance on LO and HO ( $C_L$ ), and supply voltage ( $V_{DD}$ ) and can be roughly calculated as:

$$P_{DGATES} = 2 \cdot f \cdot C_L \cdot V_{DD}^2$$
 (12)

There are some additional losses in the gate drivers due to the internal CMOS stages used to buffer the LO and HO outputs. Figure 20 shows the measured gate driver power dissipation versus frequency and load capacitance. At higher frequencies and load capacitance values, the power dissipation is dominated by the power losses driving the output loads and agrees well with the Equation 12. This plot can be used to approximate the power losses due to the gate drivers.



#### **Power Dissipation Considerations (continued)**

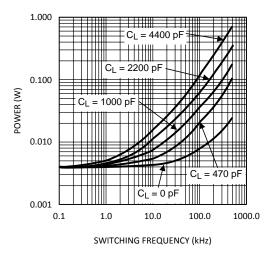


Figure 20. Gate Driver Power Dissipation (LO + HO)  $V_{CC} = 12 \text{ V}$ 

#### 10 Layout

#### 10.1 Layout Guidelines

The optimum performance of high- and low-side gate drivers cannot be achieved without taking due considerations during circuit board layout. The following points are emphasized:

- 1. Low ESR / ESL capacitors must be connected close to the IC between VDD and VSS pins and between HB and HS pins to support high peak currents being drawn from VDD and HB during the turnon of the external MOSFETs.
- 2. To prevent large voltage transients at the drain of the top MOSFET, a low ESR electrolytic capacitor and a good quality ceramic capacitor must be connected between the MOSFET drain and ground (VSS).
- 3. To avoid large negative transients on the switch node (HS) pin, the parasitic inductances between the source of the top MOSFET and the drain of the bottom MOSFET (synchronous rectifier) must be minimized.
- 4. Grounding considerations:
  - The first priority in designing grounding connections is to confine the high peak currents that charge and discharge the MOSFET gates to a minimal physical area. This will decrease the loop inductance and minimize noise issues on the gate terminals of the MOSFETs. The gate driver should be placed as close as possible to the MOSFETs.
  - The second consideration is the high current path that includes the bootstrap capacitor, the bootstrap diode, the local ground referenced bypass capacitor, and the low-side MOSFET body diode. The bootstrap capacitor is recharged on a cycle-by-cycle basis through the bootstrap diode from the ground referenced VDD bypass capacitor. The recharging occurs in a short time interval and involves high peak current. Minimizing this loop length and area on the circuit board is important to ensure reliable operation.
- 5. The resistor on the RDT pin must be placed very close to the IC and separated from the high current paths to avoid noise coupling to the time delay generator which could disrupt timer operation.

#### 10.1.1 HS Transient Voltages Below Ground

The HS node will always be clamped by the body diode of the lower external FET. In some situations, board resistances and inductances can cause the HS node to transiently swing several volts below ground. The HS node can swing below ground provided:

1. HS must always be at a lower potential than HO. Pulling HO more than -0.3 V below HS can activate parasitic transistors resulting in excessive current flow from the HB supply, possibly resulting in damage to the IC. The same relationship is true with LO and VSS. If necessary, a Schottky diode can be placed



#### **Layout Guidelines (continued)**

externally between HO and HS or LO and GND to protect the IC from this type of transient. The diode must be placed as close to the IC pins as possible in order to be effective.

- 2. HB to HS operating voltage should be 15 V or less. Hence, if the HS pin transient voltage is -5 V, VDD should be ideally limited to 10V to keep HB to HS below 15 V.
- 3. Low ESR bypass capacitors from HB to HS and from VCC to VSS are essential for proper operation. The capacitor should be located at the leads of the IC to minimize series inductance. The peak currents from LO and HO can be quite large. Any inductances in series with the bypass capacitor will cause voltage ringing at the leads of the IC which must be avoided for reliable operation.

#### 10.2 Layout Example

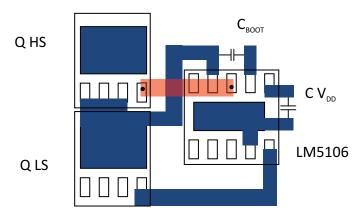


Figure 21. LM5106 Component Placement



## 11 Device and Documentation Support

#### 11.1 Trademarks

All trademarks are the property of their respective owners.

#### 11.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 11.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

#### 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 10-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
LM5106MM/NOPB	Active	Production	VSSOP (DGS)   10	1000   SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	5106
LM5106MM/NOPB.A	Active	Production	VSSOP (DGS)   10	1000   SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	5106
LM5106MM/NOPB.B	Active	Production	VSSOP (DGS)   10	1000   SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	5106
LM5106MMX/NOPB	Active	Production	VSSOP (DGS)   10	3500   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	5106
LM5106MMX/NOPB.A	Active	Production	VSSOP (DGS)   10	3500   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	5106
LM5106MMX/NOPB.B	Active	Production	VSSOP (DGS)   10	3500   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	5106
LM5106SD/NOPB	Active	Production	WSON (DPR)   10	1000   SMALL T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 125	L5106SD
LM5106SD/NOPB.A	Active	Production	WSON (DPR)   10	1000   SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	L5106SD
LM5106SD/NOPB.B	Active	Production	WSON (DPR)   10	1000   SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	L5106SD
LM5106SDX/NOPB	Active	Production	WSON (DPR)   10	4500   LARGE T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 125	L5106SD
LM5106SDX/NOPB.A	Active	Production	WSON (DPR)   10	4500   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	L5106SD
LM5106SDX/NOPB.B	Active	Production	WSON (DPR)   10	4500   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	L5106SD

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



# **PACKAGE OPTION ADDENDUM**

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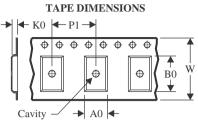
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# **PACKAGE MATERIALS INFORMATION**

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#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

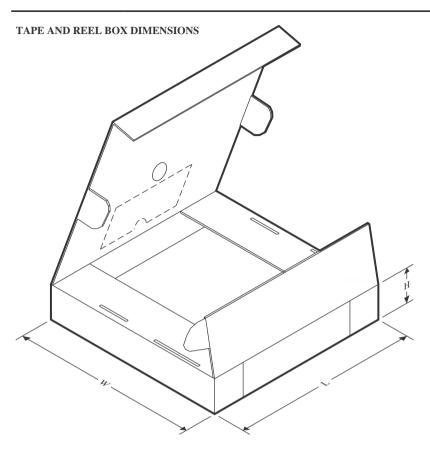


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM5106MM/NOPB	VSSOP	DGS	10	1000	177.8	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LM5106MMX/NOPB	VSSOP	DGS	10	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LM5106SD/NOPB	WSON	DPR	10	1000	177.8	12.4	4.3	4.3	1.3	8.0	12.0	Q1
LM5106SDX/NOPB	WSON	DPR	10	4500	330.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1



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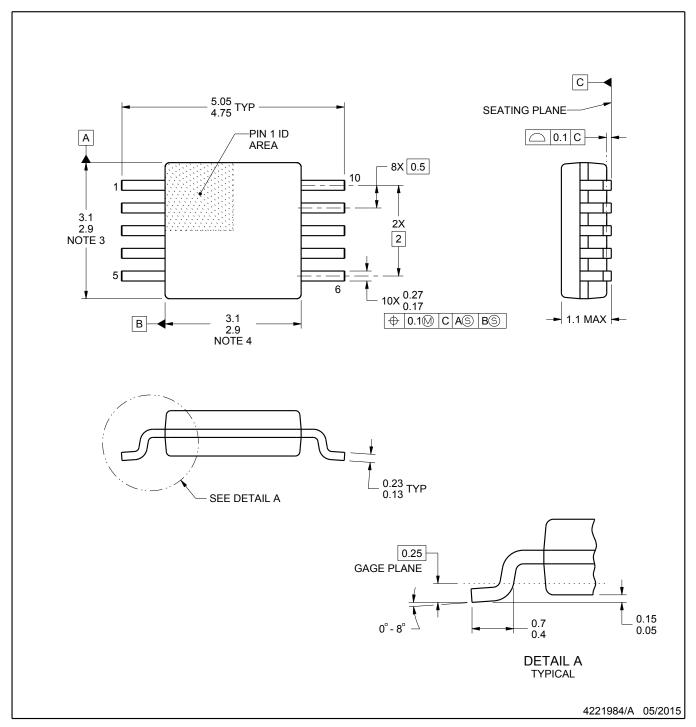


#### \*All dimensions are nominal

7 til dilliololololo di o Hollindi							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM5106MM/NOPB	VSSOP	DGS	10	1000	208.0	191.0	35.0
LM5106MMX/NOPB	VSSOP	DGS	10	3500	367.0	367.0	35.0
LM5106SD/NOPB	WSON	DPR	10	1000	208.0	191.0	35.0
LM5106SDX/NOPB	WSON	DPR	10	4500	367.0	367.0	35.0



SMALL OUTLINE PACKAGE



#### NOTES:

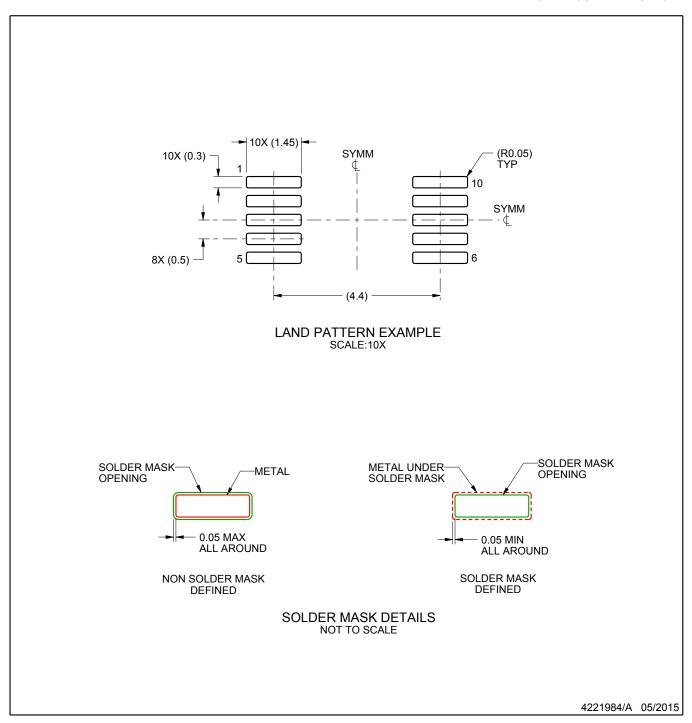
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187, variation BA.



SMALL OUTLINE PACKAGE



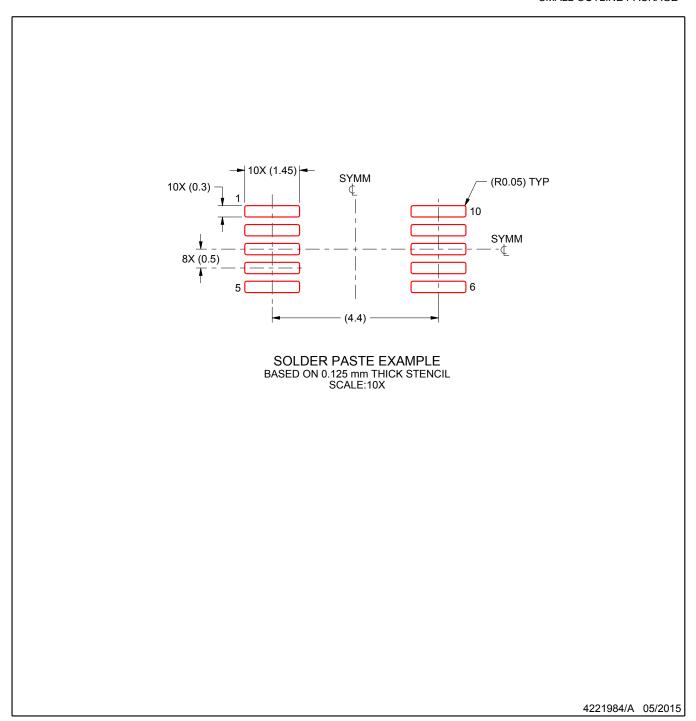
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

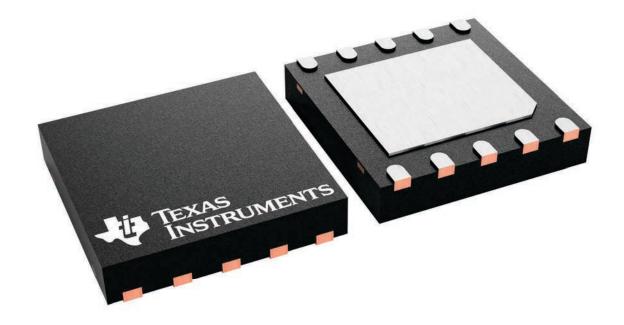
- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



4 x 4, 0.8 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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